

EMC TEST REPORT

Product Name: Smart Phone

Model Name: CP32

FCC ID: R38YLCP32A

Issued For : Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd

Floor 21, Block A, Coolpad Building, Nanshan District, Shenzhen, China

Issued By : Shenzhen LGT Test Service Co., Ltd.

Room 205, Building 13, Zone B, Zhenxiong Industrial Park, No.177, Renmin West Road, Jinsha, Kengzi Street, Pingshan District, Shenzhen, Guangdong, China

Report Number:LGT24F114EM01Sample Received Date:Jun. 24, 2024Date of Test:Jun. 24, 2024 – Jul. 10, 2024Date of Issue:Jul. 10, 2024

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TEST REPORT CERTIFICATION

Applicant:	Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd
Address:	Floor 21, Block A, Coolpad Building, Nanshan District, Shenzhen, China
Manufacturer:	Yulong Computer Telecommunication Scientific (Shenzhen) Co., Ltd
Address:	Floor 21, Block A, Coolpad Building, Nanshan District, Shenzhen, China
Product Name:	Smart Phone
Trademark:	coolpad
Model Name:	CP32
Sample Status:	Normal

APPLICABLE STANDARDS				
STANDARD TEST RESULTS				
FCC 47 CFR Part 15 Subpart B ANSI C63.4-2014	PASS			

Prepared by:

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Revision History

Rev.	Issue Date	Revisions
00	Jul. 10, 2024	Initial Issue



1. TEST SUMMARY

EMC Emission					
Standard	Test Item	Limit	Judgement	Remark	
FCC 47 CFR Part 15 Subpart B ANSI C63.4-2014	Conducted Emissions	Class B	PASS		
	Radiated Emissions Below 1GHz	Class B	PASS		
	Radiated Emissions Above 1GHz	Class B	PASS	Note 2	

Note:

- 1 "N/A" denotes test is not applicable in this Test Report
- 2 If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 40 GHz, whichever is less.



1.1 TEST LABORATORY

Company Name:	Shenzhen LGT Test Service Co., Ltd.	
Address:	Room 205, Building 13, Zone B, Zhenxiong Industrial Park, No.177, Renmin West Road, Jinsha, Kengzi Street, Pingshan District, Shenzhen, Guangdong, China	
Accreditation Certificate	A2LA Certificate No.: 6727.01	
	FCC Registration No.: 746540	
	CAB ID: CN0136	

1.2 MEASUREMENT UNCERTAINTY

Test Item	Measurement Frequency Range MHz	Uncertainty dB		
Conducted Emissions at AC mains power port	0.009 ~ 30	2.80		
Radiated Emissions	0.009 ~ 30	2.16		
Radiated Emissions	30 ~ 1000	4.40		
Radiated Emissions	1000 ~ 18000	5.49		
 Note: 1. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2. 2. The measurement uncertainty is not included in the test result. 				



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF THE EUT

Product Name:	Smart Phone
Trademark:	coolpad
Model Name:	CP32
Series Model:	N/A
Model Difference:	N/A
Adapter:	Input: 100-240V, 50-60Hz, 0.5A Output: 5V 3A, 9V 2.22A, 12V 1.67A
Battery:	Rated Capacity: 4880mAh Rated Voltage: 3.87V
Test Voltage:	AC 120V/60Hz Battery: 3.87V
Hardware Version:	V2.1
Software Version:	N/A

Note: For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.



2.2 DESCRIPTION OF THE TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possibly have effect on EMI emission level. Each of these EUT operating mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Test Mode	Description		
Mode 1	Charging+GSM link+BT+Wi-Fi+GPS+Camera recording		
Mode 2	Charging+WCDMA link+BT+Wi-Fi+GPS+Camera recording		
Mode 3	Charging+LTE link+BT+Wi-Fi+GPS+Camera recording		
Mode 4	USB Data Transmission		

Note: Only the data of worst-case mode 1 was recorded in this report.

2.3 DESCRIPTION OF THE SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Accessories Equipment

Description	Manufacturer	Model	S/N	Rating
Adapter	Shenzhen Yichengxin Electronic Technology Co., Ltd	YCX-PD20W	N/A	Input: 100-240V ~ 50/60Hz 0.5A Output: 5V 3A, 9V 2.22A, 12V 1.67A
USB-A to USB- C Cable	N/A	N/A	N/A	1m

Auxiliary Equipment

Description	Manufacturer	Model	S/N	Rating
Laptop	Lenovo	HKF-16	N/A	N/A
Earphone	VESAFE	39630078	N/A	N/A

Note:

(1) For detachable type I/O cable should be specified the length in cm in $^{\mathbb{C}}$ Length $_{\mathbb{Z}}$ column.



2.4 MEASUREMENT INSTRUMENTS LIST

Conducted Emission					
Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Until
EMI Test Receiver	R&S	ESU8	100372	2024.03.09	2025.03.08
LISN	COM-POWER	LI-115	02032	2024.03.09	2025.03.08
LISN	SCHWARZBECK	NNLK 8122	00160	2024.03.09	2025.03.08
Transient Limiter	CYBERTEK	EM5010A	E2250100049	2024.03.09	2025.03.08
Temperature & Humidity	KTJ	TA218B	N.A	2024.03.09	2025.03.08
Testing Software		EMC-I_V	1.4.0.3_SKET		
Radiated Emission					-
Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Until
EMI Test Receiver	R&S	ESU8	100372	2024.03.09	2025.03.08
Spectrum Analyzer	Keysight	N9020A	MY50530994	2024.03.09	2025.03.08
Spectrum Analyzer	Keysight	N9010B	MY60242508	2023.08.14	2024.08.13
Active loop Antenna	ETS	6502	00049544	2023.10.13	2025.10.12
Bilog Antenna	SCHWARZBECK	VULB 9168	01447	2022.12.12	2025.12.11
Horn Antenna	SCHWARZBECK	3115	10SL0060	2022.06.02	2025.06.01
Pre-amplifier (9kHz-1GHz)	EMtrace	RP01A	02017	2024.03.09	2025.03.08
Pre-amplifier (1-26.5G)	Agilent	8449B	3008A4722	2024.03.09	2025.03.08
Antenna Tower	SAEMC	BK-4AT-BS-D	SK2021093008	N.A	N.A
Temperature & Humidity	JINGCHUANG	BT-3	N.A	2024.03.11	2025.03.10
Testing Software	EMC-I_V1.4.0.3_SKET				



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 LIMITS

	Conducted Emission Limits (dBuV)					
FREQUENCY (MHz)	Clas	s A	Class B			
	Quasi-peak	Average	Quasi-peak	Average		
0.15 ~ 0.5	79.00	66.00	66 - 56 *	56 - 46 *		
0.5 ~ 5	73.00	60.00	56.00	46.00		
5 ~ 30	73.00	60.00	60.00	50.00		

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.
- (3) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor Margin Level = Measurement Value - Limit Value

The following table is the setting of the receiver

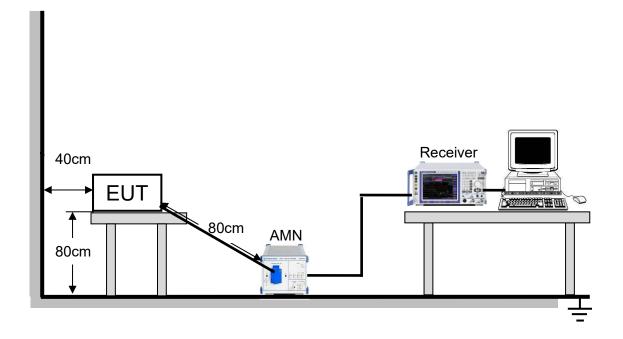
Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

3.1.2 TEST PROCEDURE

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item EUT Test Photos.



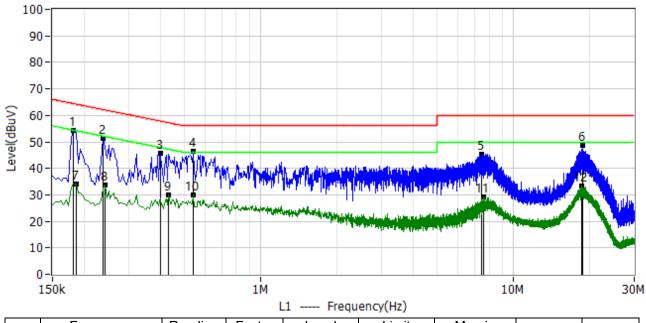
3.1.3 TEST SETUP





3.1.4 TEST RESULTS

Project: LGT24F114	Test Engineer: LiuH			
EUT: Smart Phone	Temperature: 27.1°C			
M/N: CP32	Humidity: 51%RH			
Test Voltage: AC 120V/60Hz	Test Data: 2024-06-26			
Test Mode: Charging+GSM link+BT+Wi-Fi+GPS+Camera recording				
Note:				



No.	Frequency MHz	Reading dBuV	Factor dB	Level dBuV	Limit dBuV	Margin dB	Detector	Polar
1*	0.182	43.63	10.61	54.24	64.39	-10.16	QP	L1
2*	0.238	40.80	10.61	51.41	62.17	-10.76	QP	L1
3*	0.402	35.02	10.56	45.58	57.81	-12.23	QP	L1
4*	0.542	35.74	10.57	46.31	56.00	-9.69	QP	L1
5*	7.482	34.47	11.00	45.47	60.00	-14.53	QP	L1
6*	18.710	37.19	11.57	48.76	60.00	-11.24	QP	L1
7*	0.186	23.59	10.61	34.20	54.21	-20.02	AV	L1
8*	0.242	23.29	10.60	33.89	52.03	-18.14	AV	L1
9*	0.430	19.55	10.56	30.11	47.25	-17.15	AV	L1
10*	0.542	19.43	10.57	30.00	46.00	-16.00	AV	L1
11*	7.642	18.36	11.00	29.36	50.00	-20.64	AV	L1
12*	18.534	21.76	11.56	33.32	50.00	-16.68	AV	L1



6*

7*

8*

9*

10*

11*

12*

19.090

0.182

0.374

0.534

0.774

1.826

19.090

34.99

29.00

18.71

19.06

16.78

13.41

17.55

11.58

10.56

10.59

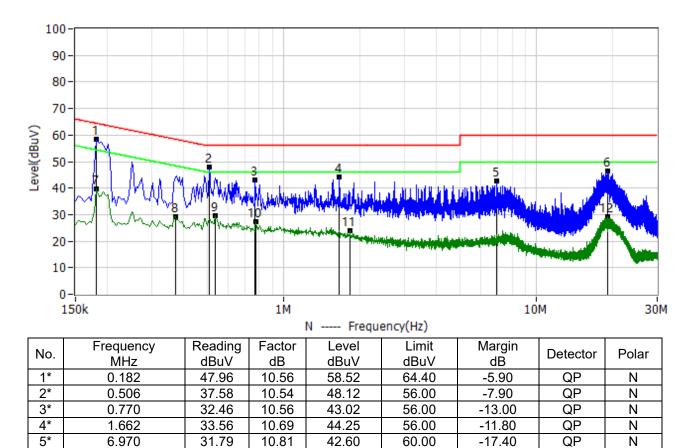
10.54

10.56

10.72

11.58

Project: LGT24F114	Test Engineer: LiuH			
EUT: Smart Phone	Temperature: 27.1°C			
M/N: CP32	Humidity: 51%RH			
Test Voltage: AC 120V/60Hz	Test Data: 2024-06-26			
Test Mode: Charging+GSM link+BT+Wi-Fi+GPS+Camera recording				
Note:				



46.57

39.56

29.30

29.60

27.34

24.13

29.13

60.00

54.40

48.40

46.00

46.00

46.00

50.00

-13.40

-14.80

-19.10

-16.40

-18.70

-21.90

-20.90

QP

AV

AV

AV

AV

AV

AV

Ν

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3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS

Below 1 GHz

Frequency	Class A	Class B	
Frequency (MHz)	Field strength	Field strength	
(101112)	(dBuV/m) (at 3m)	(dBuV/m) (at 3m)	
30 - 88	49.5	40	
88 - 216	53.9	43.5	
216 - 960	56.9	46	
Above 960	60	54	

Above 1 GHz

	Clas	ss A	Class B		
Frequency	Field s	trength	Field strength		
(MHz)	(dBuV/m) (at 3m)		(dBuV/m) (at 3m)		
	Peak	Peak Average		Average	
Above 1000	80	60	74	54	

Frequency Range of Radiated Disturbance Measurement

Highest frequency generated or Upper frequency of measurement used in the device or on which the device operates or tunes (MHz)	Range (MHz)
Below 1.705	30
1.705 - 108	1000
108 - 500	2000
500 - 1000	5000
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower

Note:

- (1) The limit for radiated test was performed according to FCC Part 15, Subpart B;
- (2) The tighter limit applies at the band edges;
- (3) The test result calculated as following: Measurement Value = Reading Level + Correct Factor, Correct Factor = Antenna Factor + Cable Loss - Amplifier Gain(if use),
 - Margin Level = Measurement Value Limit Value.

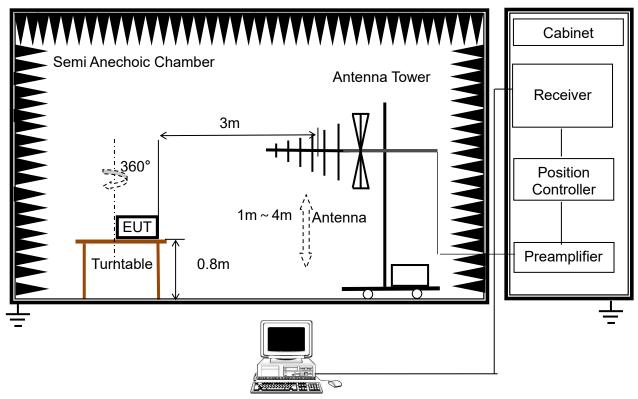
3.2.2 TEST PROCEDURE

- a. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 3 meter semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. EUT as the center to the edge of the auxiliary device, the distance from the maximum edge to the center of the antenna is 3 meter.
- c. The height of antenna is varied from 1 meter to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meter and the rotatable table was turned from 0 degrees to 360 degree to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1GHz.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

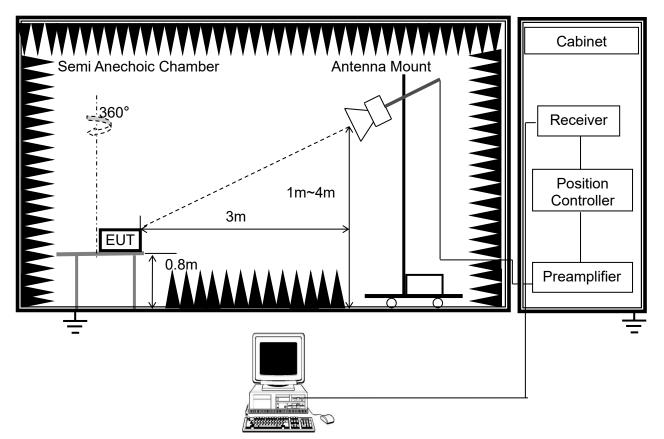


3.2.3 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz



(B) Radiated Emission Test Set-Up Frequency Above 1GHz

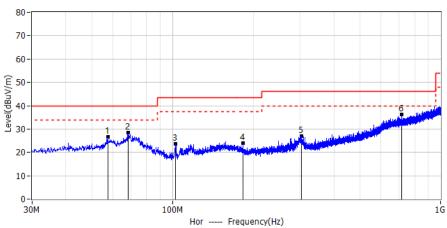




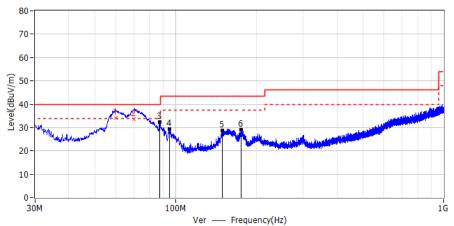
3.2.4 TEST RESULTS

BELOW 1GHZ

Project: LGT24F114	Test Engineer: Xiangdong Ma			
EUT: Smart Phone	Temperature: 25.1°C			
M/N: CP32	Humidity: 47%RH			
Test Voltage: AC 120V/60Hz	Test Data: 2024-06-26			
Test Mode: Charging+GSM link+BT+Wi-Fi+GPS+Camera recording				
Note:				



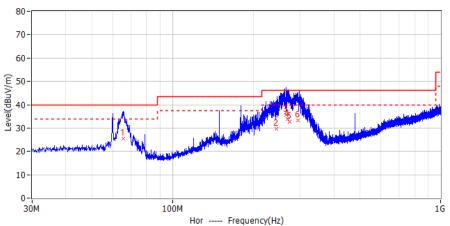
				iner inequence	(····· /			
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
INO.	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Delector	FUIdi
1*	57.403	7.90	18.83	26.73	40.00	-13.30	QP	Hor
2*	68.315	10.38	18.12	28.50	40.00	-11.50	QP	Hor
3*	102.871	7.74	15.95	23.69	43.50	-19.80	QP	Hor
4*	182.775	5.34	18.51	23.85	43.50	-19.60	QP	Hor
5*	303.661	7.01	20.03	27.04	46.00	-19.00	QP	Hor
6*	714.820	6.37	29.98	36.35	46.00	-9.60	QP	Hor



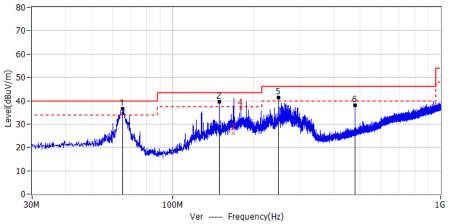
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
INO.	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Delector	FUIdi
1	59.992	15.59	18.60	34.19	40.00	-5.80	QP	Ver
2	70.245	15.69	18.00	33.69	40.00	-6.30	QP	Ver
3*	87.473	17.26	15.10	32.36	40.00	-7.60	QP	Ver
4*	95.111	14.12	15.35	29.47	43.50	-14.00	QP	Ver
5*	149.553	8.96	19.95	28.91	43.50	-14.60	QP	Ver
6*	176.228	9.78	19.19	28.97	43.50	-14.50	QP	Ver



Project: LGT24F114	Test Engineer: Xiangdong Ma	
EUT: Smart Phone	Temperature: 25.1°C	
M/N: CP32	Humidity: 47%RH	
Test Voltage: Battery	Test Data: 2024-06-26	
Test Mode: USB Data Transmission		
Note:		



				nor frequency	(112)			
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1	65.557	7.22	18.30	25.52	40.00	-14.48	QP	Hor
2	243.525	11.82	17.90	29.72	46.00	-16.28	QP	Hor
3	265.133	16.75	19.00	35.75	46.00	-10.25	QP	Hor
4	267.936	14.88	19.10	33.98	46.00	-12.02	QP	Hor
5	273.001	13.49	19.30	32.79	46.00	-13.21	QP	Hor
6	294.159	13.51	19.80	33.31	46.00	-12.69	QP	Hor

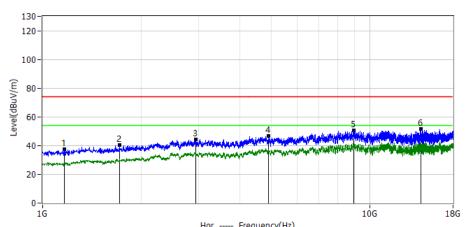


				vel Flequelic	(112)			
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1*	65.284	18.10	18.31	36.41	40.00	-3.59	PK	Ver
2*	149.916	19.52	19.98	39.50	43.50	-4.00	PK	Ver
3	168.792	6.22	19.80	26.02	43.50	-17.48	QP	Ver
4	179.979	17.95	18.80	36.75	43.50	-6.75	QP	Ver
5*	248.614	23.29	18.15	41.44	46.00	-4.56	PK	Ver
6*	479.959	13.62	24.55	38.17	46.00	-7.83	PK	Ver

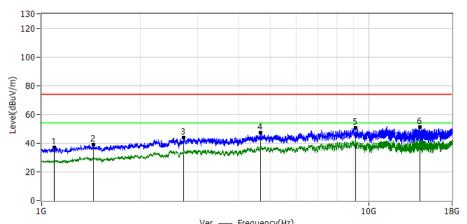


ABOVE 1GHZ

Project: LGT24F114	Test Engineer: Xiangdong Ma					
EUT: Smart Phone	Temperature: 25.1°C					
M/N: CP32	Humidity: 47%RH					
Test Voltage: AC 120V/60Hz	Test Data: 2024-06-26					
Test Mode: Charging+GSM link+BT+Wi-Fi+GPS+Camera recording						
Note:						



				Hor Frequence	y(HZ)			
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1*	1163.6000	60.89	-23.33	37.56	74.00	-36.44	PK	Hor
2*	1718.2000	59.40	-19.19	40.21	74.00	-33.79	PK	Hor
3*	2935.9000	53.34	-9.09	44.25	74.00	-29.75	PK	Hor
4*	4910.0000	53.80	-6.91	46.89	74.00	-27.11	PK	Hor
5*	8926.2000	54.41	-3.80	50.61	74.00	-23.39	PK	Hor
6*	14376.9000	50.89	0.72	51.61	74.00	-22.39	PK	Hor



Ver Frequency(Hz)								
No.	Frequency	Reading	Factor	Level	Limit	Margin	Detector	Polar
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		
1*	1093.5000	60.81	-23.94	36.87	74.00	-37.13	PK	Ver
2*	1437.7000	60.10	-21.27	38.83	74.00	-35.17	PK	Ver
3*	2721.2000	53.80	-10.18	43.62	74.00	-30.38	PK	Ver
4*	4659.2000	53.80	-6.66	47.14	74.00	-26.86	PK	Ver
5*	9134.5000	54.26	-3.74	50.52	74.00	-23.48	PK	Ver
6*	14372.6000	50.63	0.72	51.35	74.00	-22.65	PK	Ver

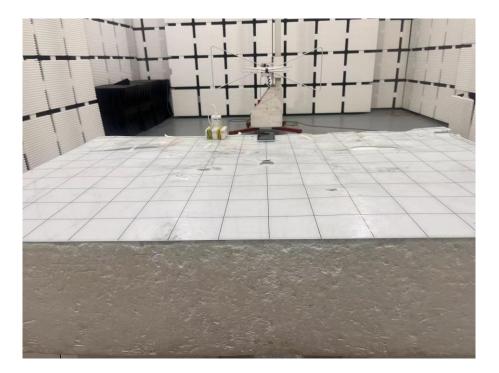


APPENDIX I - TEST SETUP

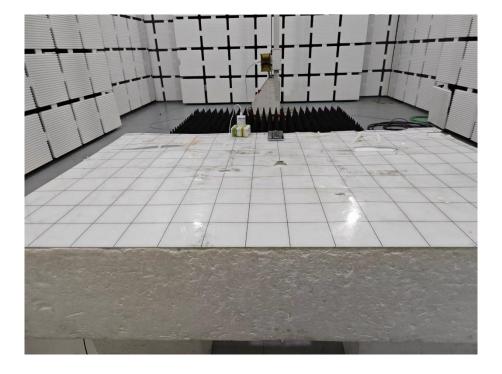


Set-up for Conducted Emission on AC Mains (CE)

Set-up for Radiated Emission (RE), Below 1GHz







Set-up for Radiated Emission (RE), Above 1GHz



APPENDIX II - PHOTOGRAPHS OF EUT CONSTRUCTIONAL DETAILS

Note: Please see the attached CP32_EUT Photos.

* * * * * END OF THE REPORT * * * *